



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Hiroto HORIKAWA

Group Art Unit: 2882

Application No.: 10/589,679

Examiner: M. ASFAW

Filed: August 16, 2006

Docket No.: 129109

For: EXPOSURE APPARATUS, EXPOSURE METHOD, AND DEVICE FABRICATING METHOD

SUBMISSION OF REPLACEMENT SHEETS OF OCTOBER 13, 2011 PTO-1449

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

The Examiner is requested to replace the PTO-1449 filed with the October 13, 2011 Information Disclosure Statement with the attached Replacement Sheets. The attached Replacement Sheets correct the issue dates for cite numbers 21 and 32. References 21 and 32 were previously submitted.

Respectfully submitted,

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Date: October 28, 2011
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Sheet 1 of 2

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129109		APPLICATION NO. 10/589,679	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hiroto HORIKAWA			
				FILING DATE August 16, 2006		GROUP 2882	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
	1	6,897,963 B1	05/24/2005	Taniguchi et al.			
	2	5,493,403	02/20/1996	Nishi			
	3	6,650,399 B2	11/18/2003	Baselmans et al.			
	4	6,341,007 B1	01/22/2002	Nishi et al.			
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	7	6,208,407 B1	03/27/2001	Loopstra			
	8	2004/0211920 A1	10/28/2004	Derksen et al.			
	9	2007/0258068 A1	11/08/2007	Horikawa			
	10	7,075,616 B2	07/11/2006	Derksen et al.			
	11	6,721,039 B2	04/13/2004	Ozawa			
	12	2002/0041377 A1	04/11/2002	Hagiwara et al.			
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	14	6,611,316 B2	08/26/2003	Sewell			
	15	6,819,414 B1	11/16/2004	Takeuchi			
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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	16	JP-A-2004-289128	10/14/2004	Japan			
	17	JP-A-11-135400	05/21/1999	Japan		X	
	18	JP-A-2000-164504	06/16/2000	Japan		X	
	19	JP-A-2001-267239	09/28/2001	Japan			
	20	JP-A-2002-198303	07/12/2002	Japan			
	21	JP-A-2002-071514	03/08/2002	Japan	X	X	
	22	JP-T-2000-505958	05/16/2000	Japan			
EXAMINER					DATE CONSIDERED		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: October 13, 2011

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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	23	JP-T-2000-511704	09/05/2000	Japan		X	
	24	JP-T-2001-513267	08/28/2001	Japan		X	
	25	JP-A-2002-158168	05/31/2002	Japan	X	X	
	26	JP-A-2000-323404	11/24/2000	Japan	X	X	
	27	JP-A-2001-223159	08/17/2001	Japan	X	X	
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	29	WO 2005/074014 A1	08/11/2005	WIPO	X		
	30	EP-1 713 113 A1	10/18/2006	European			
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	35	WO 2005/059618 A2	06/30/2005	WIPO			
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Examiner Initials	Cite No.	Including name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
	36	International Search Report issued July 11, 2008 in PCT Patent Application No. PCT/JP2007/075410.					
	37	Written Opinion issued July 11, 2008 in PCT Patent Application No. PCT/JP2007/075410.					
	38	Office Action issued September 30, 2010 in U.S. Patent Application No. 12/003,451.					
EXAMINER					DATE CONSIDERED		
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